

# AN2533/AN25

UNIVERSAL, BIPOL ±3 1/2-DIGIT (±1999-COUN1)

## **DIGITAL PANEL INSTRUMENT**

The AN2533/AN2553 breakthrough instrument design reflects Analogic's world leadership in digital panel instrumentation . . . . and the experience gained in producing more than 250,000 instruments.

Never before has the OEM user been offered so many and varied opportunities to incorporate "value-added" features into a digital panel instrument - - - increasing the profitability of his product, and exploiting fully his own design expertise. In fact, by standardizing on either of the two configurations, most OEM users can satisfy all of their 3 1/2 digit DPI requirements.

The AN2553 is the more versatile configuration. Its design includes an internal power and signal interface connector which accepts a general purpose plug-in card on which the user can install proprietary analog-interface circuitry.... or Analogic can add the special purpose circuitry during manufacture, whichever is more economical. (Typical analog-interface functions that may be provided are: ac and dc current measurement, extended range ac and dc voltage measurement, active multipole filtering, information reinforcement filtering, thermocouple or RTD temperature transducer conditioning, LVDT excitation and demodulation, frequency-to-voltage conversion, current sourcing, auto-ranging, and ultra high impedance buffering.)

The AN2553 and AN2533 both provide power and space for an optional digital circuit card for such add-in features as isolated parallel BCD output, digital linearization, and set-point control. Here again, the add-ons may be provided by the user, or, for quantity requirements, engineered and built in by Analogic.

The AN2533 provides the same advanced performance features and inherent versatility of the AN2553, except that the analog-interface connector is omitted. The basic design common to both is so flexible and adaptable that this lower cost version provides far more value-added application freedom than any conventional design.

In either configuration, exceptional confidence in high quality and reliability is warranted by: (1) Application of worst-case error analysis to ensure specification integrity throughout rated life; (2) Minimizing the component count without "cornercutting;" (3) Exclusive use of premium, field-proven components; (4) 100% burn-in of all IC's; (5) Use of CMOS digital circuitry resulting in extremely low internal temperature rise (less than 10°C); (6) Generous derating margins; (7) 100% testing of subassemblies; (8) 4-day burn-in of all completed instruments before final test; and (9) Comprehensive, detailed quality-assurance procedures.

Design features that contribute to the wide-range versatility of this design include: a true symmetrical front end; dual-slope, long-period signal integration; choice of bright, luminous, 0.55" (14mm) gas plasma or 0.43" (11mm) LED display; common-mode rejection ratios up to 160dB; normal mode rejection ratios up to 100dB; and a universal 100/117/220/240 Vac power supply.

Compare 3 1/2-Digit Instruments - Study all available specifications. Consider this instrument's potential to maximize the value added to your product. We believe you will agree that we have made available the best general purpose DPI to fulfill present and foreseeable measurement needs.

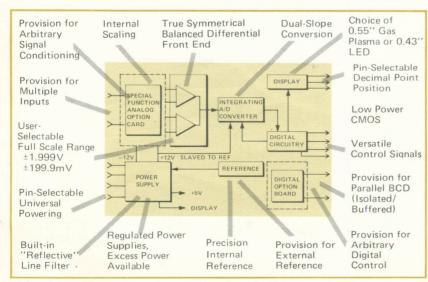


Figure 1. Simplified Block Diagram

### **FEATURES**

ACCURACY AND STABILITY

Resolution: ± 1999 counts

Error: Less than ±0.05% Rdg ±1 count

Noise: Deadband less than 0.1 count

Temperature Coefficient: <35ppm/°C typical

DISPLAY OPTIONS
 0.55" (14mm) gas plasma or 0.43" (11mm) LED, self-illuminating
 Automatic polarity
 Pin-selectable decimal points
 Dummy Zeros

UTMOST RELIABILITY

Low parts count; yet incorporating those needed for safe performance margins Cool operation: only 2 watts power consumption low-power CMOS circuitry Standard, proven, volume-production IC chips

- USE-ORIENTED INPUT CONDITIONING True-differential, balanced symmetrical inputs<sup>†</sup> Low bias current High input impedance Built-in signal offsetting capability
- VERSATILE CONTROLS
   External run/hold
   Remote display control
   User-selectable full scale range
- UNIVERSAL POWERING
  Universal transformer; pin connectable
  100, 117, 220 or 240Vac, 49 to 500Hz
  Highly regulated internal supply voltages;
  +5V, +12V, -12V with excess capability
- PROVEN INTERFERENCE REJECTION
   High CMRR & NMRR capabilities
   Built-in "reflective" line filter
- ADAPTABLE MECHANICAL PROVISIONS International DIN/NEMA standard case UL 94V-0 Rated Front-panel removeable, <sup>†</sup> easily serviced
- WIDE ENVIRONMENTAL RANGE
   Operating temperature range: -10°C to +60°C
   High rejection of electric fields
   Operational in harsh shock & vibration stresses
- OEM INSTRUMENT-TO-PRODUCT TRANSFORMATIONS

By plug-in PC-board assemblies for thermocouple and RTD temperature indicators; pH meters; load cell, bridge, and LVDT weight, force, and pressure instrumentation; etc.

 SYSTEM-COUPLING OF ANALOG INPUTS AND DIGITAL OUTPUTS

Low input bias currents: to fractions of picoamperes! Very high impedance input circuits: to 10<sup>12</sup> ohms! Isolated and buffered parallel BCD outputs Power-sharing and coupling capabilities

<sup>†</sup>U.S. Patent numbers 3718923, 3751717, 3751791 and others pending



### AN2533 & AN2553 SPECIFICATIONS

Configuration

Bipolar balanced symmetrical differential inputs

**Full-Scale Range** 

±1.999Vdc or ±199.9mVdc, user-selectable (special scaling available in OEM-quantity)

**Bias Current** 

10nA nominal, 30nA maximum Offset Current

**Dynamic Input Impedance** Normal Mode Rejection

5nA nominal, 10nA maximum 1000 megohms nominal

>30dB @ 60Hz with std, hi-freq, filter;

up to 100dB with optional lo-freq, filter

Common Mode Rejection

Isolated Digital I/O: CMV Range:

±500Vdc or peak ac CMRR:

>80dB intrinsic (See Application Data) ±2.5Vdc or peak ac-input V

Non-Isolated Digital I/O: CMV Range:

CMRR: >80dB intrinsic

Zero-Offsetting

±30 counts nominal at 1-volt full scale

Maximum Differential Input Voltage ±20V without damage Up to 160dB

Up to 100dB

Any arbitrary value consistent with maximum input voltage specifications Up to ±1000V without damage

AN2553 EXPANSION CAPABILITIES

Any arbitrary input signal scaling

As low as  $10^{-13}$  amperes

As low as 10<sup>-13</sup> amperes

As high as  $10^{12}$  ohms

Any arbitrary input transducer signal conditioning, plus filtering, amplifying, impedance-matching, and analog linearizing, etc.

ACCURACY/STABILITY

Accuracy

±0.05% of reading ±1 count

Resolution ±1999 counts Guaranteed

Monotonicity Range Tempco

35ppm of reading/°C typical, 70ppm of reading/°C maximum 20μV/°C typical

Offset Tempco Recommended Recalibration Interval 12 months

CONVERSION

Technique

Dual-slope integration, each measurement independent of the previous measurement

Control

Rate

Displayed conversion controlled by internal (clock) or external (arbitrary systemdeveloped control logic) command (low

level applied to Pin 6 of Connector J1) ~2 readings/second (internal) or any lower rate controlled by external command

Built-in, arbitrary system-developed control logic (See Application Data, page 4)

Any arbitrary rate less than 2 readings/ second, controlled by built-in logic command (See Application Data, page 4)

Input Integration Period

100 milliseconds nominal

DISPLAY

Type

**Number of Digits** 

7-segment gas plasma 0.55" (14mm) or LED 0.43" (11mm), planar

3 full-decade digits, and "1" in most significant digit position (See Ordering Guide,

page 3 and Fig. 11, for dummy zero options.)

Automatic, plus or minus sign displayed

**Decimal Point** 

Externally programmable in three positions (See Application Data, page 4)

Polarity

Overload (More than 1999 Counts)

All digits blanked; polarity and decimal point remain lighted

DIGITAL SIGNALS

(See Timing Diagram, Figure 3.)

Logic Levels (All Inputs and Outputs)

DTL/TTL/CMOS compatible. Sinks 1.6mA at low level (0 to 0.5V) and sources 40µA at high level (+3.5 ±1V)

**External Blanking** 

Low level input (on Pin 7) blanks three least significant digits Low level input (on Pin 6) retains last reading in display (See Figure 7.) Hold

Overload Low level output (on Pin 7) indicates a measurement greater than 1999 counts

Continuous (100kHz nominal) Clock

Latch High level output (on Pin J) indicates that counter contents are being transferred into latches

Rising edge (on Pin F) indicates counter carry (See Application Data) Carry

FOC Rising edge (on Pin K) signals end of conversion (EOC)

**Polarity** High logic level (on Pin 8) indicates measurement is negative

**BCD OPTION CARDS** 

Isolated and/or buffered parallel BCD outputs (See Application Data).

MTBF POWER

Input Voltage

100, 117, 220, or 240 Vac rms ±10%, 49 to 500Hz

+4.75Vdc ±5% at 30mA

43,000 hours calculated

+12Vdc ±8% at 10mA; -12Vdc ±8% at 10mA

2 watts nominal\* Consumption

**ENVIRONMENTAL & PHYSICAL** 

**Operating Temperature** Storage Temperature

**Available Output Voltage** 

**Relative Humidity** 

-25°C to +85°C (-13°F to +185°F) 0 to 95%, noncondensing

-10°C to +60°C (+14°F to +140°F)

Weight Case

**Dimensions** 

12 ounces nominal (340 grams)

High-impact molded plastic case UL 94V-0 Rated standard; metal case available as an option DIN-Standard: 96mm (3.78 inches) bezel width x 48mm (1.89 inches) bezel height x 104.9mm (4.13 inches) max. depth (see Figure 8)

<sup>\*</sup>Slightly higher with LED displays

### APPLICATION DATA

# UT SIGNAL ENHANCEMENT & INTERFERENCE REJECTION

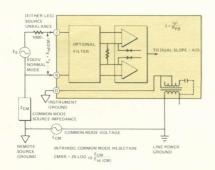
The AN2533/AN2553 exceptional overall signal interference rejection is a combination of:

- (1) The intrinsic front end (input terminal related) CMR
- (2) The normal mode input filter rejection, and
- (3) The long-time integration in the dual slope A/D converter. As a result, the user has a remarkable flexibility in obtaining accurate

normal mode (series) noise rejection.

### TRUE, BALANCED, DIFFERENTIAL INPUT & CMR

The very high impedance, true balanced symmetrical differential front end (not to be confused with some pseudo-differential types) provides the user with the versatility for making direct additive or subtractive measurements of local or remote noisy inputs from one or more sources, referenced to arbitrary system power or instrument ground. The digitized output represents the true difference of input potentials, and, therefore, it is insensitive (see specifications) to voltage variations and fluctuations common to both terminals. Thus, the input differential circuitry itself can contribute to the rejection of common mode potentials referred to instrument ground. In addition, because of the high degree of isolation of the power transformer, excellent rejection ratios are achieved for common mode voltages up to ±350V with respect to power line ground.



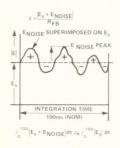


Figure 4. Transformation of Common Mode Signals,  $E_{CM}$ , to Normal Mode Signals,  $E_{td(CM)}$ , NMR, and Rejection by Integration

### NORMAL MODE REJECTION

Normal mode interference signals, resulting either from conversion of common mode voltage to differential voltage or from additive (series) interferences, may be filtered out by a combination of passive or active input filtering and conversion integration. The standard DPI (see specs) is supplied with a nominal 20Hz low pass single-pole filter which, in combination with the integration effect, yields approximately 30dB rejection at 50/60Hz. There is ample provision within the AN2533/53 to incorporate either lower frequency and multipole passive filters and/or active filters which utilize the input differential amplifiers as their active elements (see Example A, page 5), so as to obtain normal mode rejections up to 100dB or greater at 50/60Hz.

#### INTERFERENCE REJECTION BY INTEGRATION

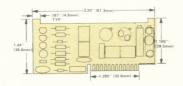
Remaining interference components (after front-end terminal related and input filter rejection) are still further reduced by the 100ms integration. For net signal level-to-peak noise ratios higher than one, the bipolar integration is complete so that, even for non-synchronous 50 or 60Hz interference, rejection greater than 20dB will be achieved.

Overall common mode rejection ratios of greater than researched example, 80dB intrinsic CMRR, +60dB NMRR, +20dB integration rejection) at 50 or 60Hz with 1000 ohm unbalance in either input line can readily be obtained!

### ANALOG FUNCTION CARD

Using either the Analogic AN450 General Purpose Analog Function Card with Filter (see Fig. 11), which is typically capable of handling 30 arbitrary components, including potentiometers, dual in-line ICs, and discrete 2-and 3-lead components, or by designing his own such card, the user may build in proprietary circuitry for any arbitrary signal conditioning, excitation, or linearizing function, utilizing the available excess regulated power, stable reference, and additional input terminals for optimum system compatibility.

The General Purpose Analog Function (kluge) Card, with a pre-engineered layout for optimum component space utilization, is held securely in the DPI by connector J3 and the case without the need for any additional mounting hardware.



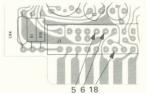


Figure 5. Typical Kluge Card Layout

Figure 6. PC-Board Scaling Connections

#### ARBITRARY SCALING

With a 10,000 $\Omega$  feedback resistor (RFB) connected as shown in Figure 2, the DPI is normally calibrated at the factory for a full-scale range of 1 volt/1,000 counts. A thermally tracking internal resistor, 1.1kilohms, may be connected in parallel with the 10,000 ohm resistor by a jumper between positions 5 and 6 on the main assembly PC board (AN2533) or by connections on the analog option board (AN2553). The parallel resistance of 1,000 ohms provides the user-selectable sensitivity of 100mV/1,000 counts (100 $\mu$ V/count). Any other sensitivity may be obtained by a net resistance between positions 6 and 18 according to the formula R = Voltage/1,000 Counts.

0.1mA

### HOLD

To hold a displayed reading, gate a HOLD command (the comparator output shown in Figure 2) with the rising edge of EOC (available at pin K), and then generate a DTL low level signal (HOLD). When applied to Pin 6 of the DPI connector, the HOLD signal will keep the last conversion displayed, while the DPI continues to update the measurement internally. When HOLD is removed, the next valid measurement is transferred to the display latches.

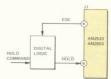


Figure 7. Generating a Hold Command

#### ANALOGIC LIBRARY OF SPECIAL FUNCTION CARDS

#### **DIGITAL CIRCUIT OPTIONS**

AN404 Function PC Card DIN Standard
AN406 Latched, Buffered Parallel BCD Output Card

AN408 Isolated, Buffered Parallel BCD Output Card

### ANALOG CIRCUIT OPTIONS

AN450 Analog Function PC Card with Input Filter
AN451 Analog Function PC Card without Input Filter
AN452 Thermocouple Cold-Junction Compensation Card

AN453 RTD Temperature Card
AN454 Input Filter Card

AN455 Industrial Current Receiver Card
AN456 Industrial Voltage Receiver Card
AN461 True RMS AC Voltmeter Card
AN462 Power Line Voltage Monitor Card

AN463 Microvolt Receiver Card
AN466 Linearized Thermocouple Card



ATION DATA The examples below are only a few of the essentially limitless applications of the AN25 indicate the wide range of applications, versatility, and ease of using this digital panel income.

### mble A Precision Current Meter

To measure current from amperes to picoamperes, simply select the standard 100mV/1,000 count DPI sensitivity and install the appropriate shunt resistance. Depending on the signal amplitudes and interferences, design protective clamps, low leakage FET buffers, and multipole filters. Appropriately guard for higher sensitivity operation by eliminating leakage current paths.

Digitize the output in any arbitrary engineering units by modifying the shunt resis-
tance between Pins 6 and 18 of J3. By connecting either end of the shunt to analog
ground, or by other means, assure circuit conformance to common mode limits.

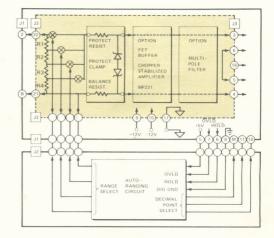
F.S. RANGE	UNIT	SHUNT, R
2.000 Amp	1mA	0.10052
200.0mA	100μΑ	1.000Ω
20.00mA	10µА	10.0052
2.000mA	1µА	100.0Ω
200.0µА	100nA	1.000KΩ
20.00μΑ	10nA	10.00ΚΩ
2.000μΑ	1nA	100.0K \$2
200.0nA	100pA	1.000MΩ
20.00nA	10pA	10.00MS2
2.000nA	1pA	100.0MΩ

### Build An Extended Range Voltmeter

To measure any voltage from kilovolts to microvolts, use either of the selectable standard DPI sensitivities and the appropriate voltage divider network. Depending upon whether a single-range or multiple-range voltmeter is desired, design suitable switching circuits to be activated either by externally programmed range select signals, or optionally, by range control signals developed on the digital function card. Protect the input circuitry with resistive and clamping components, and introduce an optional FET buffer, chopper stabilized amplifier, or standard amplifier module such as the Analogic MP221 if needed in very low level signal applications. Incorporate an optimal filter to obtain the necessary signal enhancement. Measured voltages may be

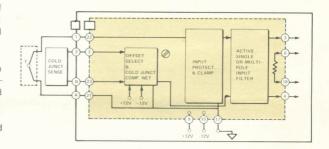
scaled in arbitrary engineering units by suitable modifications to the input divider network alone, or coupled with appropriate scaling resistors,  $R_{\rm FB}$ .

	SING	LE-RA	MULTIPLE-RANGE			
	1000V	100V	10V	EITHER		
R1	999K	990K	900K	9M	900K	
R2	1 K	10K	100K	900K	90K	
R3	0	0	0	90K	9K	
R4	0	0	0	10K	1K	



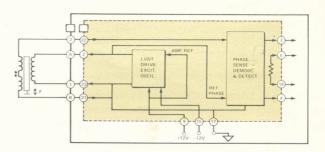
### Construct A Thermocouple Temperature Indicator

Cold-junction-compensated temperature indicators, utilizing any type of thermocouple, with excellent common mode (greater than 160dB!) and normal mode (greater than 100dB!) rejection can easily be constructed with just a few components. A semiconductor or resistive cold junction sensing element, stabily powered by the DPI +12V power reference, can generate an offset and cold-junction-compensation variable voltage which can be directly subtracted (or added) from the thermocouple-developed voltage via the true differential balanced input circuitry. Input resistor and zener clamps may provide protection, and filter components as shown in "A" above may form an active two-pole filter. The appropriate resistor across Pins 6 and 18 of J3 scales the output directly in temperature-related engineering units.



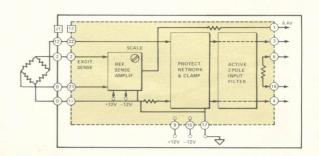
### Develop An LVDT Position Or Force Indicator

The excitation winding of an LVDT may be driven over a wide range of frequencies by an excitation oscillator powered by the ±12V regulated supplies and amplitude regulated by the precision +12V supply. The combined differential winding output of the LVDT can then be phase-sensitive demodulated in a simple switching circuit whose phase reference is derived from the excitation oscillator. The filter output of the phase sensitive demodulator can then be applied directly to the differential inputs of the DPI. Again, the output may be scaled in any desired force or linear units by choosing the appropriate resistor across Pins 6 and 18 of J3.

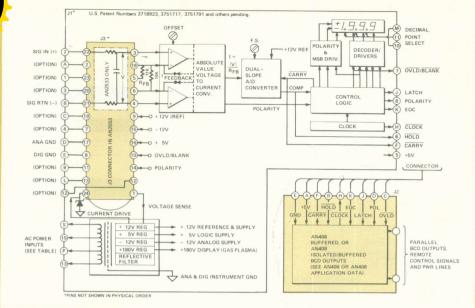


### Engineer A Ratiometric Load Cell Meter

The ratiometric capability of the AN2533/2553 may be exploited to perform ratiometric measurements of bridge transducer outputs with an accuracy independent of the external excitation supply variations. Available input pins may be utilized to sense the voltage across the bridge via a reference sense amplifier whose output may be applied via Analog Function Card Connector J1, Pin 1, to control the DPI reference. The differential output of the bridge may be scaled, offset, or amplified, or may be applied directly to the differential inputs. As described above, the scaling resistor between Pins 6 and 18 of J3 converts the output to arbitrary engineering units.







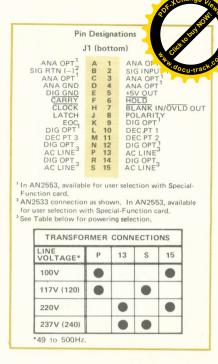


Figure 2. Functional Block Diagram

### Operating Features & Principles of Operation

As shown in Figure 2, the AN2533 contains a balanced signal enhancement input filter; a floating true differential front end; an absolute-voltage-to-current converter; a dual-slope ratiometric, current-to-count integrating analog-to-digital converter; clock-driven logic control circuitry, decoders, drivers and displays; and regulated power supplies derived from the secondary windings of a universal transformer.

Signal input to connector J1 is conditioned by the built-in filter (AN2533) or by arbitrary signal conditioning on the analog option card inserted in internal connector J3 (AN2553), resulting in a potential difference (V) at J3, pins 3 and 4, connected to the non-inverting inputs of the differential input amplifiers. The conditioned signal input (V) develops a unidirectional signal current (I), whose magnitude depends on the value of the selected feedback resistance (RFB), according to the simple Ohm's Law formula shown in Figure 2. The signal current linearly charges a high quality, low leakage, integrating capacitor during the signal integration phase of the dual slope conversion. The current generation circuitry also includes the polarity sensing for display.

Under control of the 100kHz clock-driven logic, the signal integration phase lasts 10,000 counts, thus adding to the overall signal enhancement by providing very high rejection of normal mode interfering noise. At the end of the 10,000 counts, the CARRY control signal causes the integrator to switch into the reference integration phase, during which the integrating capacitor is discharged at a constant rate determined by a current derived from the precision +12V reference until the comparator changes state. The precision resistor network determining the integrating reference current is mounted on the same substrate as the built-in selectable feedback resistance (RFB). Thus maximum thermal tracking of ratio-determining dual-slope performance components is obtained. This contributes to the exceptional overall thermal stability of the conversion. Moreover, because the signal integration phase is at least 5 times as long as the reference integration phase (10,000 counts to a maximum of 2,000 counts), noise disturbances are reduced significantly in the output.

The count accumulated during the reference integration phase is latched into the storage register, decoded, and, in addition to the polarity sensed in the current generator, used to update the display about twice a second for optimal flicker-free readings. When the count exceeds 1999, the Control Logic generates an overload (OVLD) signal which blanks the decimal digits while leaving the polarity sign and the selected decimal point lighted.

In addition to decimal point programming, the user may blank the least three significant digits or may choose to hold a displayed conversion by applying DTL-compatible signals at the designated terminals of J1. It is of interest to note that the instrument continues to update its digitized measurement, making available a valid display after the HOLD signal is released.

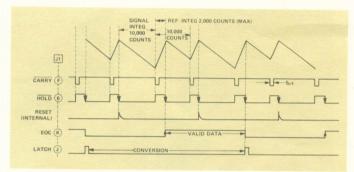


Figure 3. Timing Diagram

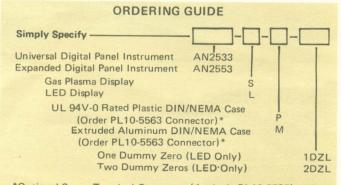
DTL/TTL-compatible digital output signals of LATCH, CARRY, EOC, HOLD, and CLOCK, as well as the OVLD and POLARITY signals, are available at connector J1, and are related to the charge-discharge cycle of the integrating capacitor as shown in the timing diagram of Figure 3.

### **Analog Function Card**

Connector J3, when utilized, brings to the analog function card a number of input signal connections, as shown, and all power sources and their ground return references for use in such signal conditioning circuits as described in the Application Data.

### **Digital Function Card**

There is an excess of +5V to power the snap-in digital option card on which isolated and/or buffered BCD outputs are generated. Connections are made via the standard panel instrument connectors. (See Application Data, page 6.)



\*Optional Screw-Terminal Connector (Analogic PL10-5535) available for solderless wiring for plastic or metal case (See Figure 9)

### APPLICATION DATA

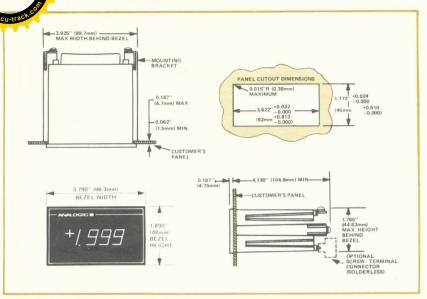


Figure 8. Panel Mounting and Outline Dimensions

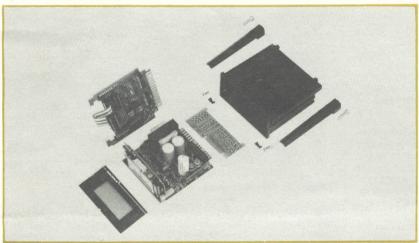


Figure 10. Complete DPI and Additional Function Cards

For LED displays only, either one (1DZL) or two (2DZL) "dummy" zeros may be added to the right end of the digital readout. These zero digits are "fixed"; that is, they always display "0" (1DZL) or "00" (2DZL) for all input signals within the specified range.



- \*Add to end of Order Code. Factory installation only
- \*\*For positive inputs, negative sign does not light. For overload inputs, decimal point and middle horizontal segments of dummy zeros are lit; negative sign lights for negative overload only.

Figure 11. "Dummy" Zero Display

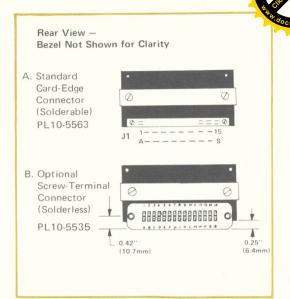


Figure 9. Rear Panel Connectors (metal case option shown)

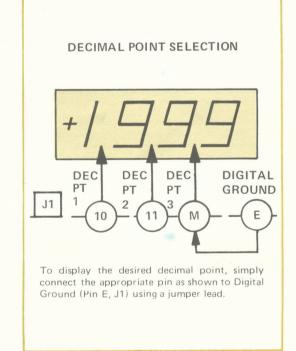


Figure 12. Decimal Point Position Terminals

NEED APPLICATIONS HELP?

CONSULT NEAREST ANALOGIC SALES OFFICE OR REPRESENTATIVE.



ANALOGIC CORPORATION = Audubon Road = Wakefield, Massachusetts 01880 Tel. (617) 246-0300 = TWX (710) 348-0425 = Telex 94-9307 ANALOGIC INTERNATIONAL = Audubon Road = Wakefield, Massachusetts 01880 Tel. (617) 246-0300 = TWX (710) 348-0425 = Telex 94-9307 ANALOGIC AG = Kanalstrasse 15 = Postfach CH-8152 = Glattbrugg = Switzerland Tel. (41) 1-810-0666 = Telex 845-59699 ANALOGIC LIMITED = 68 High Street = Weybridge, Surrey KT13 8BN = England Tel. (44) 932-41251 = Telex 851-928030 ANALOGIC REGIONAL OFFICES = Cipripnati Ohio (606) 371-0064 = San Jose Calif. (408) 247-6401

Cincinnati, Ohio (606) 371-0064 San Jose, Calif. (408) 247-6401 Tustin, Calif. (714) 838-7243 Garland, Texas (214) 681-0483 Houston, Texas (713) 777-6360

AVAILABLE FROM:





# APPLICATION DATA



Setup

# KONING EN HARTMAN



telex 31528

# ANALOGIC,

### **GENERAL**

- To operate your AN2553 Digital Panel Instrument, a "KLUGE" card must be inserted in the internal J3 socket on the main PC-board assembly and connections made on that card to the input differential amplifiers. (See the AN2533/AN2553 Data Sheet.)
- 2. The KLUGE card may be either:
  - A custom-designed card manufactured by Analogic; or
  - b) Analogic card AN450, containing a standard input filter; or
  - c) Analogic General Purpose Card AN451, or
  - A card designed and produced by the user to interface with the AN2553, mating with connector J3 on the main PC-assembly of AN2553.

### INSTRUCTIONS

- A. If the KLUGE card incorporates an input-connecting circuit such as in category a), b), or d) above, then:
  - (1) Plug the card into connector J3.
  - (2) Attach signal inputs to the appropriate external J1 terminals as determined by the card-mounted circuitry.

- (3) Attach the source power to the appropriate power input terminals as shown in the table of Powering Connections on the Data Sheet.
- B. If the KLUGE card is a general-purpose Analogic AN451, then:
  - Identify the instrument connector (J1) terminals to which the signal inputs, SIG IN (+) and SIG RTN (-), are to be connected.
  - (2) Refer to the J1-J3 interconnection table below, and determine the J3 terminals at which the signal inputs will be present after they have been connected as required by step (1) above.
  - (3) Install any desired signal-conditioning circuitry between the P3 edge-connector terminals on the general purpose card.
  - (4) Plug the card into mating J3 connector.
  - (5) Attach signal inputs to the selected J1 terminals; attach power to appropriate J1 terminals according to the instructions shown in the AN2533/ AN2553 Data Sheet.
- C. The AN2553 is now ready for operation. See Data Sheet for Scaling Instructions.

#### J1 - J3 CONNECTIONS FOR AN2553

INTERNAL EXTERNAL AN2553 OR J1 CIRCUIT CONNECTION		J3		EXTERNAL J1 O CONNECTION	INTERNAL R AN2553 CIRCUIT	
REF SENSE		1	24		REF DRIVE	
	J1 - A	2	23	J1 — 1		
*SIG IN (+)	1.1	3	22	J1 - 2		
*SIG RTN (-)		4	21	J1 — B		
FEEDBACK		5	20	J1 - 3		
FEEDBACK		6	19	J1 — C		
	J1 - 4	7	18		FEEDBACK	
DIG GND	J1 — E	8	17	J1 — D		
+12V REF		9	16	J1 - 5	+5V	
OVLD/BLNK		10	15		-12V	
	J1 — 9	11	14	J1 – 8	POLARITY	
	J1 - 12	12	13	J1 — L		

<sup>\*</sup>Inputs to Differential Amplifiers after signal conditioning.



### CERTIFICATE OF CALIBRATION

ANA and tiona	LOGIC CERTIFIES that it meets or ex	ceeds all of the requi	el Instrument has b	Serial een duly inspected and n its published mechan ng methods that preserv	tested pricing	ical and oner
	E: The following te	sts were performed at imum burn-in at a nom 5G's for 30 seconds at	ninal 50°C and at no	minal line voltage unless	s otherwise	specified.
1.	CALIBRATION Zero Span +	• 7 mV for -	+ 001 Reading - 001 Reading	en libre		
	Positive Inputs (mV)	Reading		Negative Inputs (mV)	Reading	
	000	000		000	000	
	+ 400	+ 399 + 400 + 401		- 400	- 399 - 400 - 401	
	+ 800	+ 799 + 800 + 801		- 800	- 799 - 800 - 801	
	+ 1800	+ 1798 + 1799 + 1800 + 1801 + 1802		- 1800	- 1798 - 1799 - 1800 - 1801 - 1802	
II. III.	DISPLAY TEST All numerals are of OVERRANGE	100				
IV.	SUPPLY VOLTA	1.000V				
V.	COMMON MOD Conditions: Apply Apply	Return				
VI.	Change in Reading MISCELLANEOUS					
	<ul><li>a) All three Decima</li><li>b) External Display</li></ul>	Points externally progra Blanking	ammable			1
16-5000	004 REV. 2					
			0.0	5-25-82		

Date\_

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### The minimum connections required for use as a conventional measurement instrument are:

### 1. Signal Input

Single Ended: Connect (+) side of signal input to J1-2; connect (-) side of signal input to J1-B and J1-D.

Differential Input:\* Connect (+) side of signal input to J1-2; connect (-) side of signal input to J1-B; connect analog ground to Pin J1-D.

### 2. AC Input

For 100Vac: connect ac line between J1-P and J1-15

For 117Vac: connect ac line between J1-P and J1-S

For 220Vac: connect ac line between J1-13 and J1-15

For 240Vac: connect ac line between J1-13 and J1-S.

### 3. Decimal Point

DP1 — connect J1-E to J1-10 to light the decimal between the MSD and hundreds digit [1.888]

DP2 — connect J1-E to J1-11 to light the decimal between the hundreds and tens digit [18.88]

DP3 — connect J1-E to J1-M to light the decimal between the tens and ones digit [188.8]

4. For the AN2553, a kluge card must be installed in J3, (on motherboard). See product data sheet.

See Product Data Sheet for maximum common mode voltages.